

Notice of References Cited	Application/Control No. 10/614,627	Applicant(s)/Patent Under Reexamination NGUYEN, PHILIP D.	
	Examiner George Suchfield	Art Unit 3676	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,218,038	06-1993	Johnson et al.	524/541
	B	US-5,253,711	10-1993	Mondshine, Thomas C.	166/300
	C	US-5,393,810	02-1995	Harris et al.	524/56
	D	US-5,520,250	05-1996	Harry et al.	166/278
	E	US-5,609,207	03-1997	Dewprashad et al.	166/276
	F	US-5,948,734	09-1999	Sinclair et al.	507/219
	G	US-2003/0188872	10-2003	Nguyen et al.	166/308
	H	US-6,668,926	12-2003	Nguyen et al.	166/281
	I	US-2004/0000402	01-2004	Nguyen et al.	166/280
	J	US-2004/0040713	03-2004	Nguyen et al.	166/295
	K	US-6,725,931	04-2004	Nguyen et al.	166/280.2
	L	US-6,729,404	05-2004	Nguyen et al.	166/280.2
	M	US-6,887,834	05-2005	Nguyen et al.	507/221

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.